

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/813,714	AOYAMA, CHIAKI	
	<b>Examiner</b> Luke D. Ratcliffe	<b>Art Unit</b> 3662	

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
356/4.04,3.14,4.03,4.05,22,20,21	4/14/2006	LDR
EAST text search	4/14/2006	LDR
ECLA search	4/14/2006	LDR
IEEE search	4/14/2006	LDR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner